

**Search Notes**

Application/Control No.

10/621,755

Examiner

Leila Malek

Applicant(s)/Patent under  
Reexamination

HAN, KE

Art Unit

2611

**SEARCHED**

| Class | Subclass | Date      | Examiner |
|-------|----------|-----------|----------|
| 375   | 362      | 8/30/2007 | L.M.     |
| 375   | 355      | 8/30/2007 | L.M.     |
| 375   | 354      | 8/30/2007 | L.M.     |
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**INTERFERENCE SEARCHED**

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| 375   | 362      | 8/30/2007 | L.M.     |
| 375   | 355      | 8/30/2007 | L.M.     |
| 375   | 354      | 8/30/2007 | L.M.     |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|                      | DATE      | EXMR |
|----------------------|-----------|------|
| EAST                 | 8/30/2007 | L.M. |
| IEEE                 | 8/30/2007 | L.M. |
| GOOGLE               | 8/30/2007 | L.M. |
| Inventor Name Search | 8/30/2007 | L.M. |
| Consulted M. Ghayour | 8/30/2007 | L.M. |
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